

Pb Free Plating Product

DK48N75



70V,68A N-Channel Trench Process Power MOSFET

General Description

The DK48N75 is N-channel MOS Field Effect Transistor designed for high current switching applications. Rugged EAS capability and ultra low $R_{DS(ON)}$ is suitable for PWM, load switching especially for E-Bike controller applications.

Features

- $V_{DS}=70V$; $I_D=68A@V_{GS}=10V$;
 $R_{DS(ON)}<8.4m\Omega @V_{GS}=10V$
- Special Designed for E-Bike Controller Application
- Ultra Low On-Resistance
- High UIS and UIS 100% Test

Application

- 48V E-Bike Controller Applications
- Hard Switched and High Frequency Circuits
- Uninterruptible Power Supply



Schematic Diagram

$$V_{DS} = 70 V$$

$$I_D = 68A$$

$$R_{DS(ON)} = 7m\Omega$$

Table 1. Absolute Maximum Ratings (TA=25°C)

Symbol	Parameter	Value	Unit
V_{DS}	Drain-Source Voltage ($V_{GS}=0V$)	70	V
V_{GS}	Gate-Source Voltage ($V_{DS}=0V$)	±25	V
$I_{D(DC)}$	Drain Current (DC) at $T_c=25^\circ C$	68	A
$I_{D(DC)}$	Drain Current (DC) at $T_c=100^\circ C$	47.6	A
$I_{DM(pluse)}$	Drain Current-Continuous@ Current-Pulsed (Note 1)	272	A
dv/dt	Peak Diode Recovery Voltage	30	V/ns
P_D	Maximum Power Dissipation($T_c=25^\circ C$)	85	W
	Derating Factor	0.57	W/°C
E_{AS}	Single Pulse Avalanche Energy (Note 2)	342	mJ
T_J, T_{STG}	Operating Junction and Storage Temperature Range	-55 To 175	°C

Notes 1. Repetitive Rating: Pulse width limited by maximum junction temperature

2. EAS condition: $T_J=25^\circ C, V_{DD}=33V, V_G=10V, I_D=37A$

Table 2. Thermal Characteristic

Symbol	Parameter	Value	Unit
$R_{\theta JC}$	Thermal Resistance, Junction-to-Case	1.77	$^{\circ}\text{C}/\text{W}$

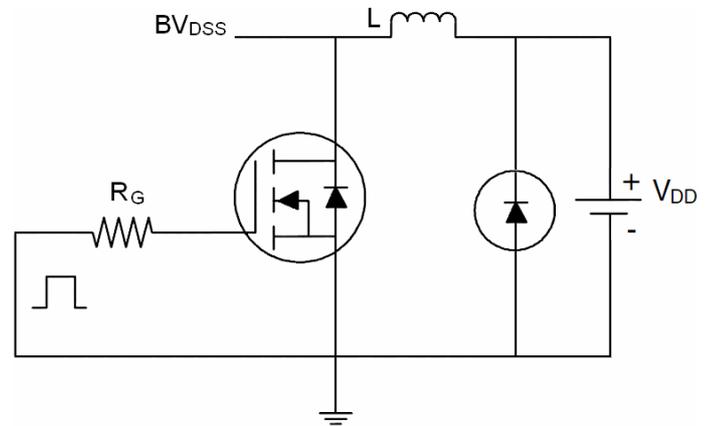
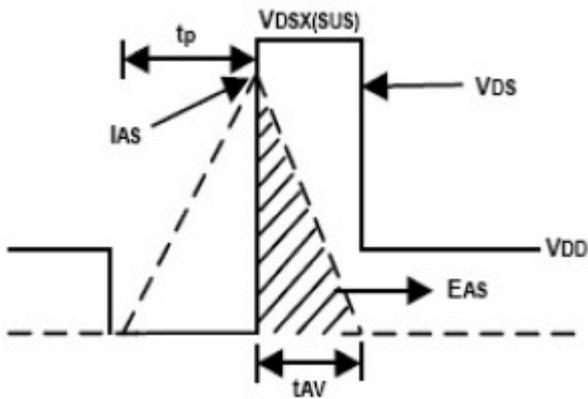
Table 3. Electrical Characteristics (TA=25 $^{\circ}\text{C}$ unless otherwise noted)

Symbol	Parameter	Conditions	Min	Typ	Max	Unit
On/Off States						
BV_{DSS}	Drain-Source Breakdown Voltage	$V_{GS}=0\text{V}, I_D=250\mu\text{A}$	70			V
I_{DSS}	Zero Gate Voltage Drain Current(Tc=25 $^{\circ}\text{C}$)	$V_{DS}=68\text{V}, V_{GS}=0\text{V}$			1	μA
I_{DSS}	Zero Gate Voltage Drain Current(Tc=125 $^{\circ}\text{C}$)	$V_{DS}=68\text{V}, V_{GS}=0\text{V}$			10	μA
I_{GSS}	Gate-Body Leakage Current	$V_{GS}=\pm 25\text{V}, V_{DS}=0\text{V}$			± 100	nA
$V_{GS(th)}$	Gate Threshold Voltage	$V_{DS}=V_{GS}, I_D=250\mu\text{A}$	2		4	V
$R_{DS(ON)}$	Drain-Source On-State Resistance	$V_{GS}=10\text{V}, I_D=40\text{A}$		7	8.4	m Ω
Dynamic Characteristics						
g_{FS}	Forward Transconductance	$V_{DS}=10\text{V}, I_D=15\text{A}$	18			S
C_{iss}	Input Capacitance	$V_{DS}=25\text{V}, V_{GS}=0\text{V},$ $f=1.0\text{MHz}$		3006		pF
C_{oss}	Output Capacitance			360		pF
C_{rss}	Reverse Transfer Capacitance			167		pF
Q_g	Total Gate Charge	$V_{DS}=50\text{V}, I_D=40\text{A},$ $V_{GS}=10\text{V}$		64		nC
Q_{gs}	Gate-Source Charge			13.4		nC
Q_{gd}	Gate-Drain Charge			26.2		nC
Switching Times						
$t_{d(on)}$	Turn-on Delay Time	$V_{DD}=30\text{V}, I_D=2\text{A}, R_L=15\Omega$ $V_{GS}=10\text{V}, R_G=2.5\Omega$		9		nS
t_r	Turn-on Rise Time			11		nS
$t_{d(off)}$	Turn-Off Delay Time			19		nS
t_f	Turn-Off Fall Time			23		nS
Source-Drain Diode Characteristics						
I_{SD}	Source-Drain Current(Body Diode)			68		A
I_{SDM}	Pulsed Source-Drain Current(Body Diode)			272		A
V_{SD}	Forward On Voltage ^(Note 1)	$T_J=25^{\circ}\text{C}, I_{SD}=40\text{A}, V_{GS}=0\text{V}$		0.79	0.95	V
t_{rr}	Reverse Recovery Time ^(Note 1)	$T_J=25^{\circ}\text{C}, I_F=75\text{A}$ $di/dt=100\text{A}/\mu\text{s}$		34		nS
Q_{rr}	Reverse Recovery Charge ^(Note 1)			69		nC
t_{on}	Forward Turn-on Time	Intrinsic turn-on time is negligible(turn-on is dominated by L_S+L_D)				

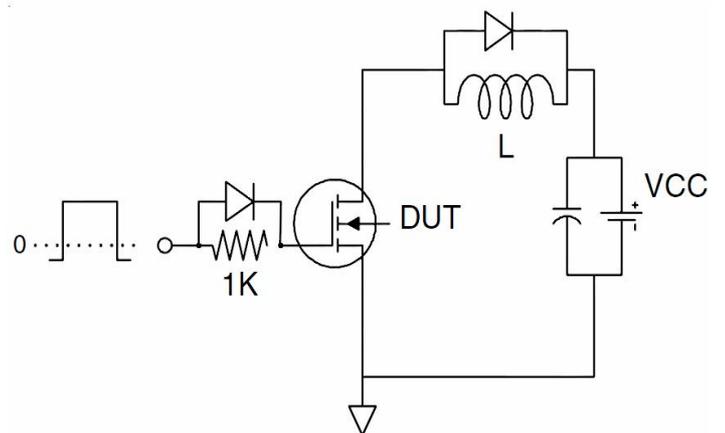
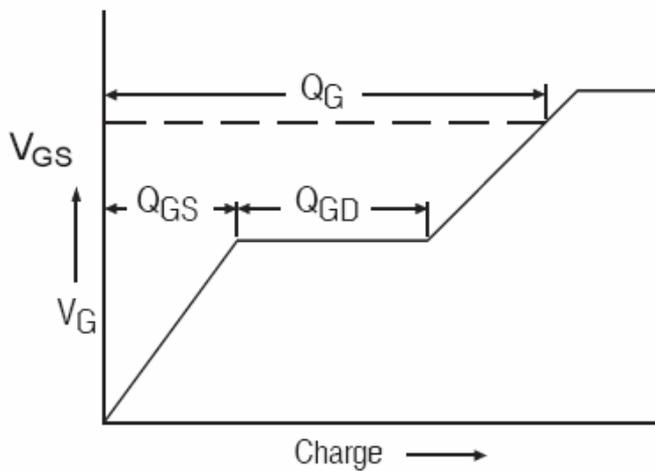
Notes 1. Pulse Test: Pulse Width $\leq 300\mu\text{s}$, Duty Cycle $\leq 1.5\%$, $R_G=25\Omega$, Starting $T_J=25^{\circ}\text{C}$

Test Circuit

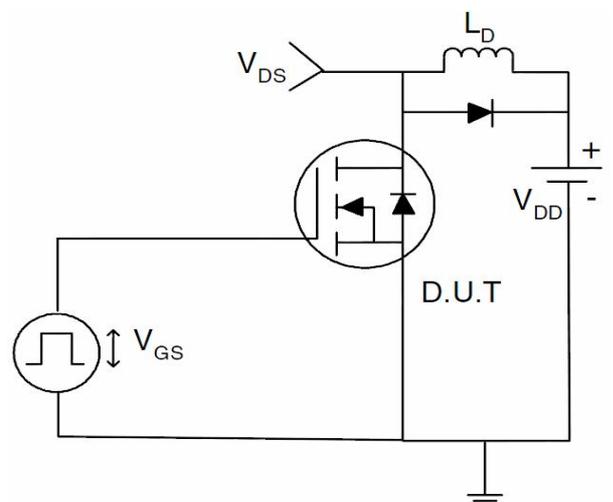
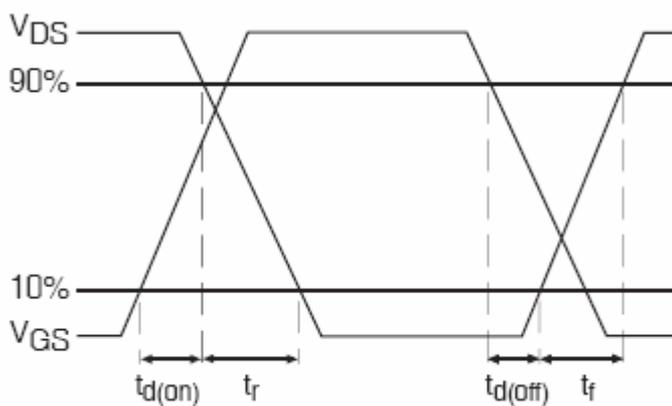
1) E_{AS} Test Circuits



2) Gate Charge Test Circuit:



3) Switch Time Test Circuit:



TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS (Curves)

Figure1. Safe Operating Area

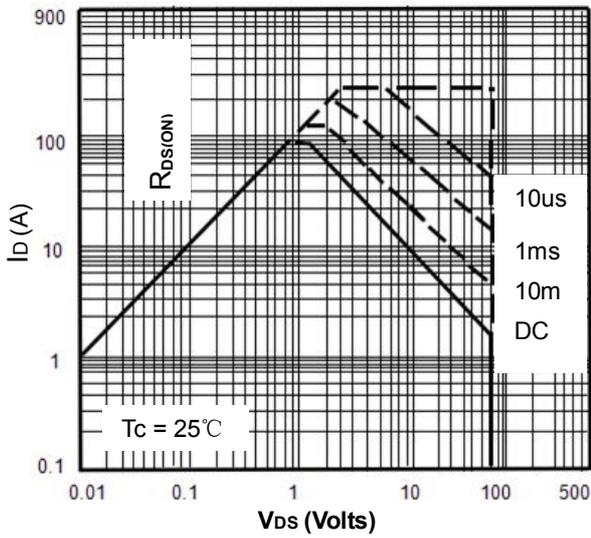


Figure2. Source-Drain Diode Forward Voltage

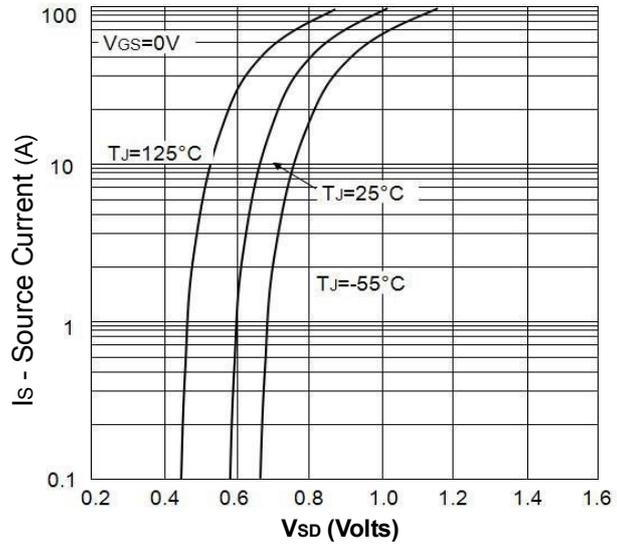


Figure3. Output Characteristics

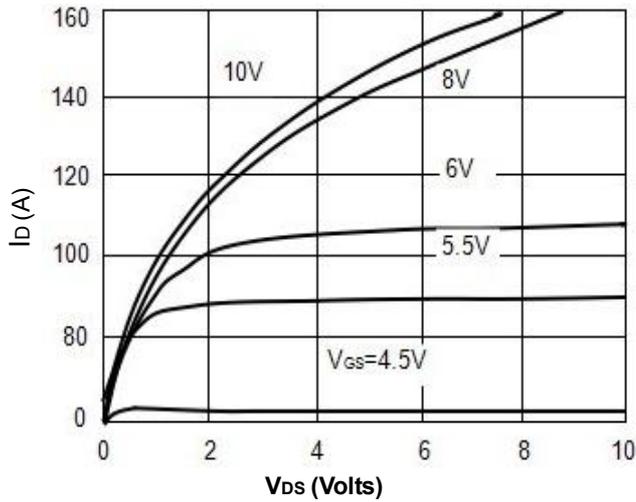


Figure4. Transfer Characteristics

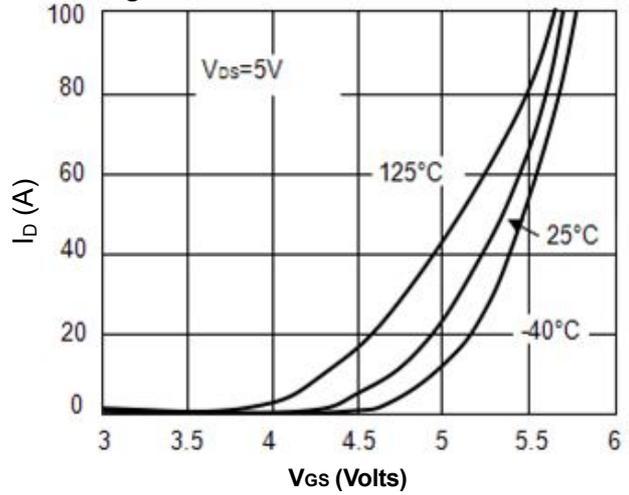


Figure5. Static Drain-Source On Resistance

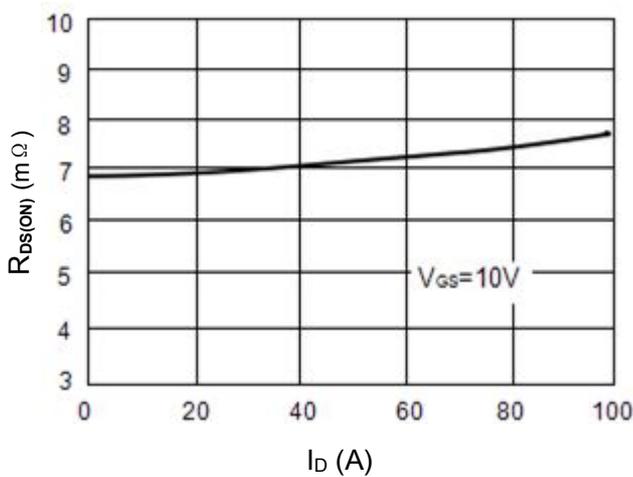


Figure6. RDS(ON) vs Junction Temperature

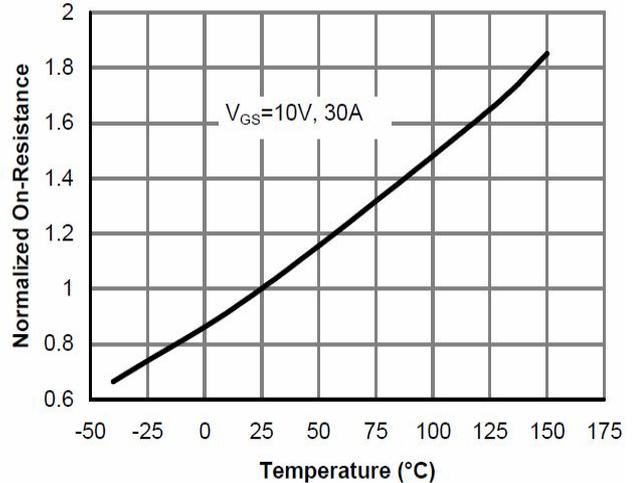


Figure7. BV_{DSS} vs Junction Temperature

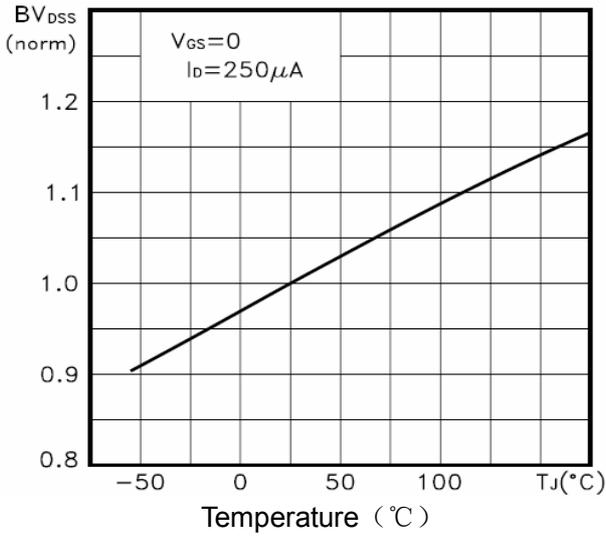


Figure8. $V_{GS(th)}$ vs Junction Temperature

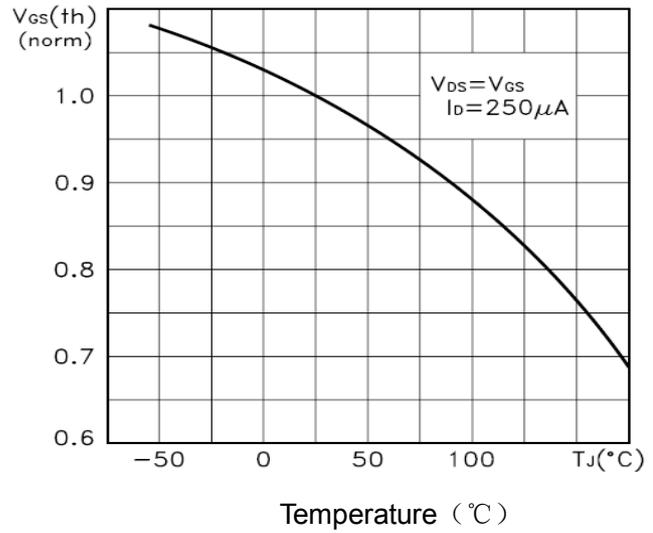


Figure9. Gate Charge Waveforms

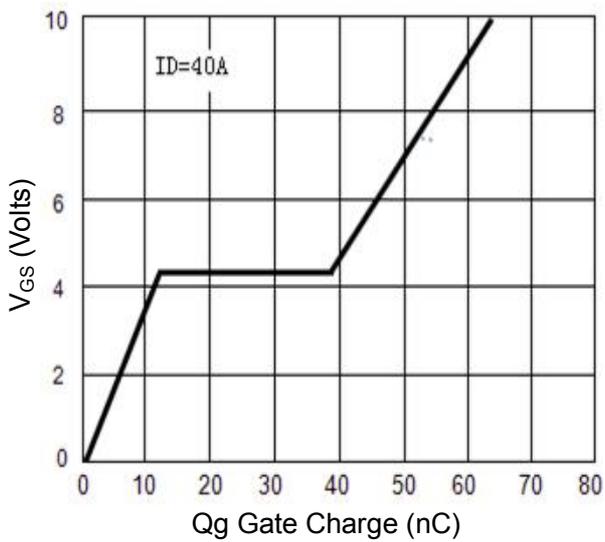


Figure10. Capacitance

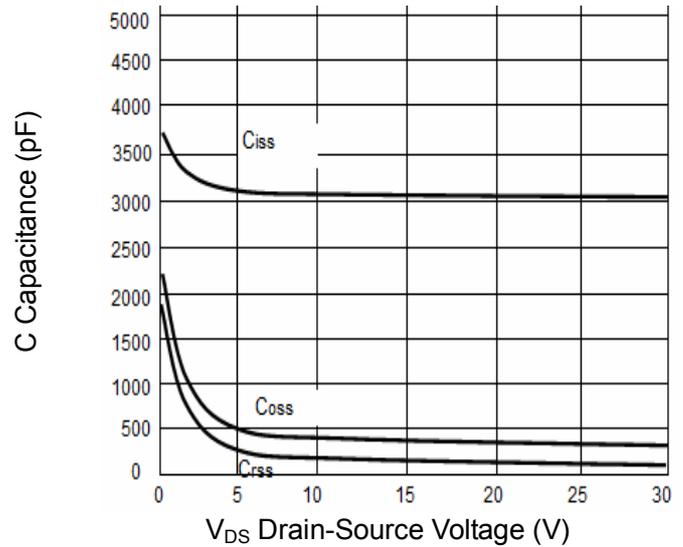


Figure11. Normalized Maximum Transient Thermal Impedance

